

Notice of References Cited	Application/Control No. 10/785,655	Applicant(s)/Patent Under Reexamination INOUE, KENJI	
	Examiner Barbara Summons	Art Unit 2817	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,201,457	03-2001	Hickernell, Thomas S.	333/193
*	B	US-6,937,113	08-2005	Ohashi et al.	333/133
*	C	US-6,975,180	12-2005	Nakamura et al.	333/133
*	D	US-5,789,845	08-1998	Wadaka et al.	310/334
	E	US-			
	E	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 7-38376	02-1995	Japan	Watanabe et al.	-----
	O	JP 2004-23655	01-2004	Japan	Yamamoto et al.	-----
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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